

<b>Notice of References Cited</b>		Application/Control No. 10/708,227	Applicant(s)/Patent Under Reexamination LEE ET AL.	
		Examiner Toniae M. Thomas	Art Unit 2822	Page 1 of 1

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*	B	US-2003/0132438 A1	07-2003	Jang, Wen-Yueh	257/68
*	C	US-5,804,851	09-1998	Noguchi et al.	257/304
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**NON-PATENT DOCUMENTS**

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